



FORM PTO-1449	Atty. Docket No.: M61.12-0333	Appl. No.: 09/804,117
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:	
	Chris Thrasher et al.	
	Filing Date	Group Art:
	March 12, 2001	---

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
T.L.	AA	5,241,619	08/31/93	Schwartz et al.	395	2
	AB	5,509,104	04/16/96	Lee et al.	395	2.65
	AC	5,649,057	07/15/97	Lee et al.	395	2.65
	AD	5,677,990	10/14/97	Junqua	395	2.64
	AE	5,983,177	11/09/99	Wu et al.	704	244
	AF	5,805,772	09/08/98	Chou et al.	395	2.64
	AG	5,625,748	04/29/97	McDonough et al.	395	2.6
	AH	4,802,231	01/31/89	Davis	382	34
	AI	5,710,864	01/20/98	Juang et al.	395	2.47
	AJ	5,710,866	01/20/98	Alleva et al.	395	2.65
✓	AK	5,566,272	10/15/96	Brems et al.	395	2.4

FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Class	Sub Class	Translation Yes No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

T.L.	AL	WORD-BASED ACOUSTIC CONFIDENCE MEASURES FOR LARGE-VOCABULARY SPEECH RECOGNITION. Asela Gunawardana et al. Microsoft Corporation. Redmond, WA.
↓	AM	CONTINUOUS HIDDEN MARKOV MODELING FOR SPEAKER-INDEPENDENT WORD SPOTTING. J. Robin Rohlicek et al. BBN System and Technologies Corporation, Cambridge, MA 1989 IEEE
↓	AN	A HIDDEN MARKOV MODEL BASED KEYWORD RECOGNITION SYSTEM. Richard C. Rose et al. Lincoln Laboratory, MIT 1990 IEEE

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Tim Lao

DATE CONSIDERED:

4/26/01

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Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
T.L.	AA	5,712,957	01/27/98	Waibel et al.	395	2.49
↓	AB	5,797,123	08/18/98	Chou et al.	704	256
↓	AC	6,029,124	02/22/00	Gillick et al.	704	200

FOREIGN PATENT DOCUMENTS

Document No.	Date	Country	Class	Sub Class	Translation Yes No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

T.L.	AD	CONFIDENCE MEASURES AND THEIR APPLICATION TO AUTOMATIC SPEECH RECOGNITION. Fil Alleva et al. Microsoft Corporation, Redmond, WA.
↓	AE	CONFIDENCE MEASURES FOR THE SWITCHBOARD DATABASE. Stephen Cox et al. Speech Research Department, AT & T Bell Labs, NJ. 1996 IEEE
↓	AF	LARGE VOCABULARY WORD SCORING AS A BASIS FOR TRANSCRIPTION GENERATION. P. Jeanrenaud et al. BBN Systems and Technologies, Cambridge, MA

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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

T.L.	AA	LVCSR LOG-LIKELIHOOD RATIO SCORING FOR KEYWORD SPOTTING. Michel Weintraub. SRI International Speech Technology and Research Program. Menlo Park, CA 1995 IEEE
↓	AB	WORD-BASED CONFIDENCE MEASURES AS A GUIDE FOR STACK SEARCH IN SPEECH RECOGNITION. Chalapathy V. Neti et al. IBM T. J. Watson Research Center, Yorktown Heights, NY 1997 IEEE.
	AC	WHISTLER: A TRAINABLE TEXT-TO-SPEECH SYSTEM. ICSLP 96 Microsoft Corporation Redmond, WA.
	AD	MICROSOFT WINDOWS HIGHLY INTELLIGENT SPEECH RECOGNIZER WHISPER. Xuedong Huang et al. Microsoft Corporation. Redmond, WA 1995 IEEE

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